## Notice of References Cited Application/Control No. 10/535,759 Examiner Dimple N. Bodawala Applicant(s)/Patent Under Reexamination BRAUNGARDT ET AL. Art Unit Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2,413,109 A	12-1946	EUGENE LEIPOLD; et. al.	425/432
*	В	US-2,532,049 A	11-1950	PAUL WITTKE EMIL	425/424
*	C	US-4,238,177 A	12-1980	Crile et al.	425/150
*	D	US-4,941,813 A	07-1990	Grubb et al.	425/195
*	Е	US-5,248,466 A	09-1993	Russell, III, William N.	264/72
*	F	US-5,770,244 A	06-1998	Braungardt et al.	425/443
*	G	US-6,119,804 A	09-2000	Owen, Thomas E.	181/113
*	Н	US-6,162,041 A	12-2000	Kobayashi, Shigeru	425/421
*	1	US-6,758,665 B2	07-2004	Cichos, Sigmund P.	425/254
	J	US-		·	
	Κ	US-			
	L	US-			
	М	US-			- A

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	•		-		
	0					
	Р	·				
	Q					
	R					
	S				,	
	Т					

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	w	
	x	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.